

Notice of References Cited	Application/Control No. 10/721,521	Applicant(s)/Patent Under Reexamination TAKEDA ET AL.	
	Examiner Hiep Nguyen	Art Unit 2816	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,434,533	07-1995	Furutani, Kiyohiro	327/538
*	B	US-6,114,845	09-2000	Capici et al.	323/313
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NON-PATENT DOCUMENTS

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